



**ALPHA & OMEGA**  
SEMICONDUCTOR

**AON6590A**

**40V N-Channel MOSFET**

### General Description

- Trench Power MV MOSFET technology
- Low  $R_{DS(ON)}$
- Low Gate Charge
- Optimized for fast-switching applications
- RoHS and Halogen-Free Compliant

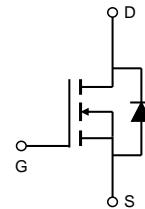
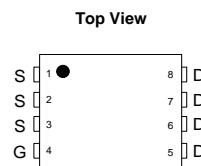
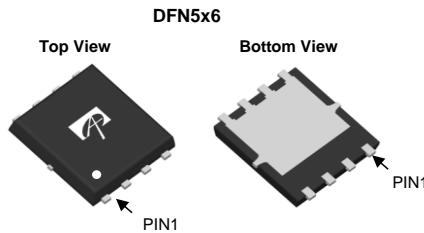
### Applications

- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial

### Product Summary

$V_{DS}$	40V
$I_D$ (at $V_{GS}=10V$ )	300A
$R_{DS(ON)}$ (at $V_{GS}=10V$ )	< 0.99mΩ
$R_{DS(ON)}$ (at $V_{GS}=4.5V$ )	< 1.5mΩ

100% UIS Tested  
100%  $R_g$  Tested



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AON6590A	DFN 5x6	Tape & Reel	3000

### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	40	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current <sup>A</sup>	$I_D$	300	A
$T_C=100^\circ C$		225	
Pulsed Drain Current <sup>C</sup>	$I_{DM}$	900	
Continuous Drain Current <sup>A</sup>	$I_{DSM}$	67	A
$T_A=70^\circ C$		54	
Avalanche Current <sup>C</sup>	$I_{AS}$	65	A
Avalanche energy <sup>C</sup>	$E_{AS}$	634	mJ
$V_{DS}$ Spike	10μs	$V_{SPIKE}$	V
Power Dissipation <sup>B</sup>	$P_D$	208	W
$T_C=100^\circ C$		83	
Power Dissipation <sup>A</sup>	$P_{DSM}$	7.3	W
$T_A=70^\circ C$		4.7	
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	°C

### Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient <sup>A</sup> $t \leq 10\mu s$	$R_{θJA}$	14	17	°C/W
Maximum Junction-to-Ambient <sup>A,D</sup> Steady-State		40	50	°C/W
Maximum Junction-to-Case	$R_{θJC}$	0.45	0.6	°C/W

**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	40			V
$\text{I}_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{DS}=40\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$			1 5	$\mu\text{A}$
$\text{I}_{\text{GSS}}$	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$			$\pm 100$	nA
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.3	1.8	2.3	V
$\text{R}_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=20\text{A}$ $T_J=125^\circ\text{C}$		0.78	0.99	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=20\text{A}$		1.17	1.55	
$\text{g}_{\text{FS}}$	Forward Transconductance	$V_{DS}=5\text{V}, I_D=20\text{A}$		100		S
$\text{V}_{\text{SD}}$	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$		0.66	1	V
$\text{I}_S$	Maximum Body-Diode Continuous Current				160	A
<b>DYNAMIC PARAMETERS</b>						
$\text{C}_{\text{iss}}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=20\text{V}, f=1\text{MHz}$		8320		pF
$\text{C}_{\text{oss}}$	Output Capacitance			1438		pF
$\text{C}_{\text{rss}}$	Reverse Transfer Capacitance			85		pF
$\text{R}_g$	Gate resistance	f=1MHz	0.5	1.15	1.8	$\Omega$
<b>SWITCHING PARAMETERS</b>						
$\text{Q}_{\text{g}}(10\text{V})$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=20\text{V}, I_D=20\text{A}$		100		nC
$\text{Q}_{\text{g}}(4.5\text{V})$	Total Gate Charge			45		nC
$\text{Q}_{\text{gs}}$	Gate Source Charge			25		nC
$\text{Q}_{\text{gd}}$	Gate Drain Charge			7		nC
$t_{\text{D(on)}}$	Turn-On Delay Time	$V_{GS}=10\text{V}, V_{DS}=20\text{V}, R_L=1.0\Omega, R_{\text{GEN}}=3\Omega$		19		ns
$t_r$	Turn-On Rise Time			7		ns
$t_{\text{D(off)}}$	Turn-Off Delay Time			69		ns
$t_f$	Turn-Off Fall Time			10		ns
$t_{\text{rr}}$	Body Diode Reverse Recovery Time	$I_F=20\text{A}, dI/dt=400\text{A}/\mu\text{s}$		26		ns
$\text{Q}_{\text{rr}}$	Body Diode Reverse Recovery Charge	$I_F=20\text{A}, dI/dt=400\text{A}/\mu\text{s}$		83		nC

A. The value of  $R_{\text{JJA}}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{ C}$ . The Power dissipation  $P_{\text{DSM}}$  is based on  $R_{\text{JJA}} \leq 10\text{s}$  and the maximum allowed junction temperature of  $150^\circ\text{ C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=150^\circ\text{ C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width 10us limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{ C}$ .

D. The  $R_{\text{JJA}}$  is the sum of the thermal impedance from junction to case  $R_{\text{JJC}}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 $\mu\text{s}$  pulses, duty cycle 0.5% max.

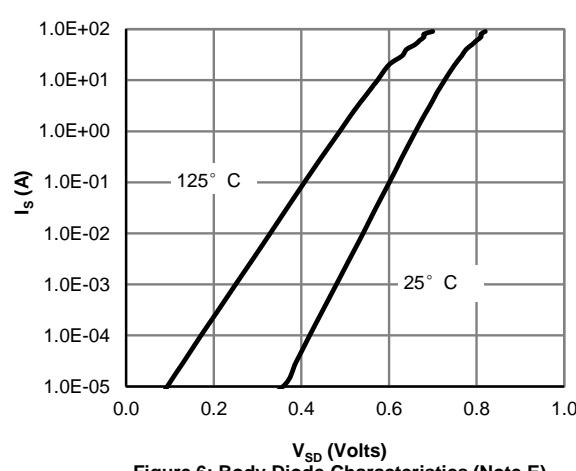
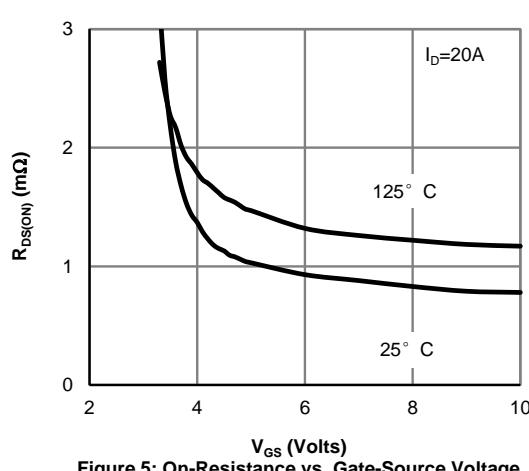
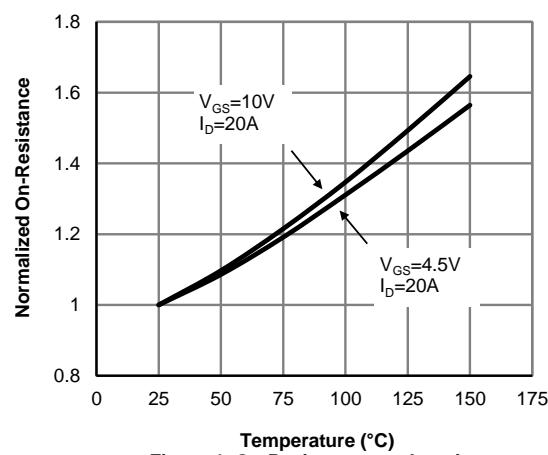
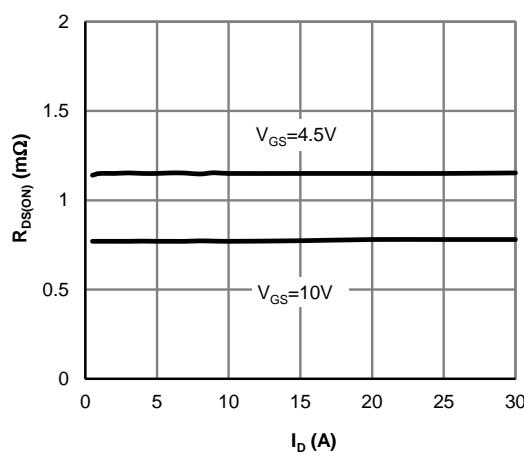
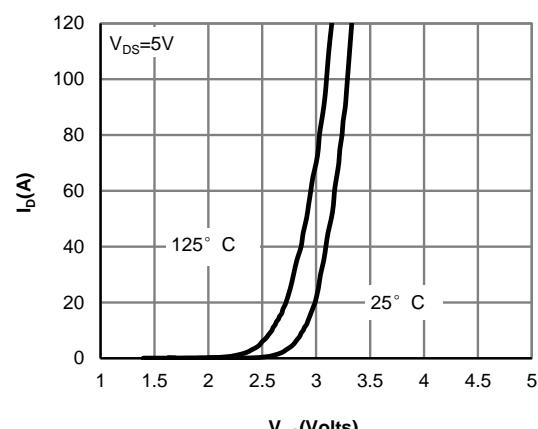
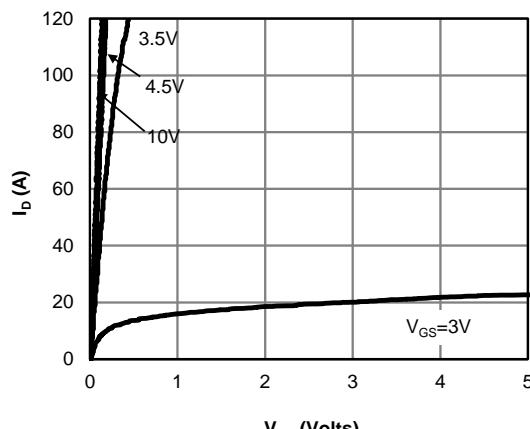
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=150^\circ\text{ C}$ . The SOA curve provides a single pulse rating.

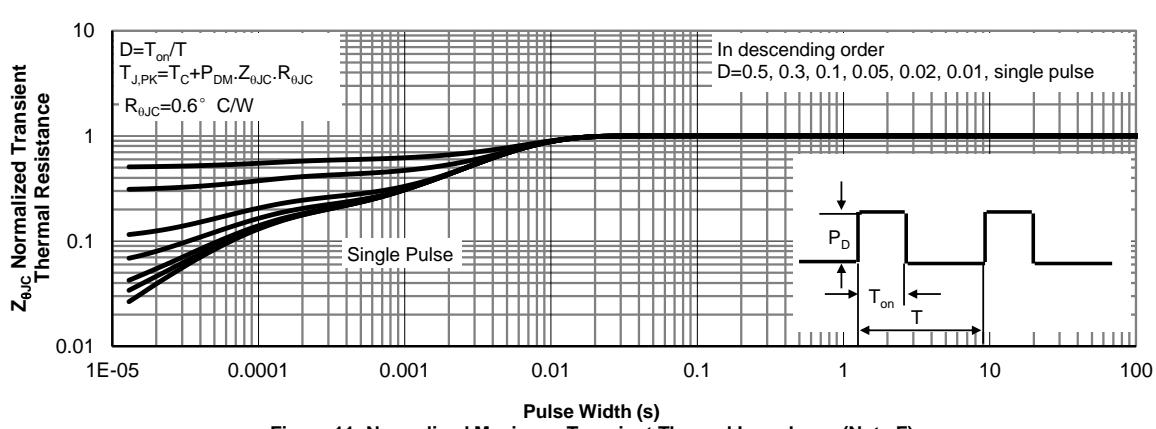
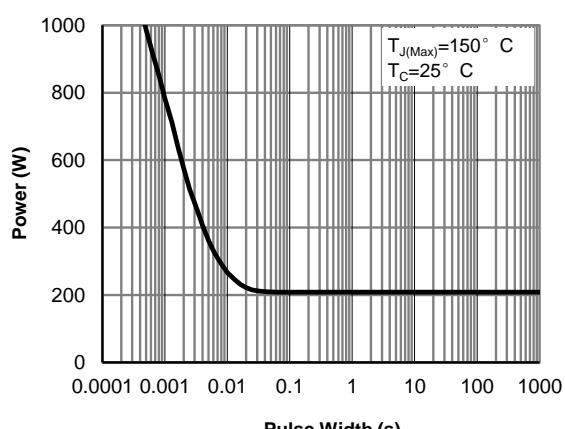
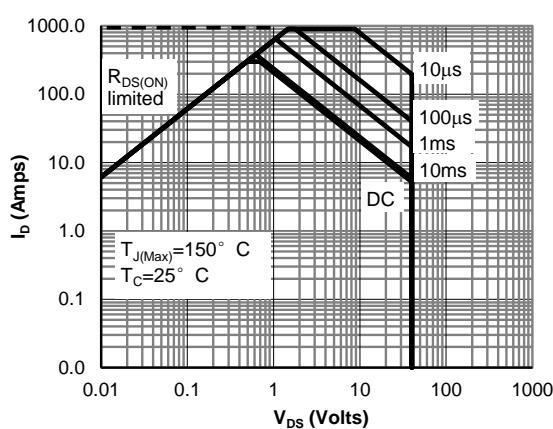
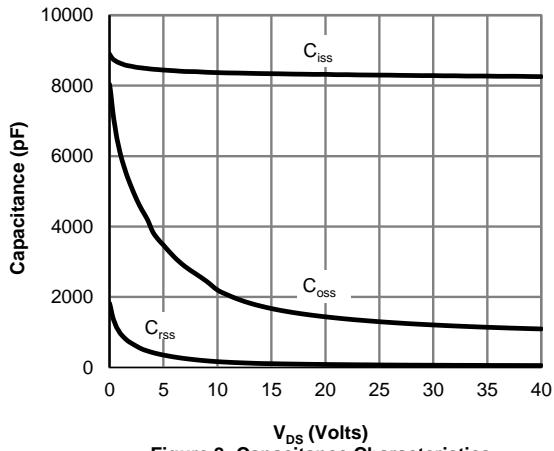
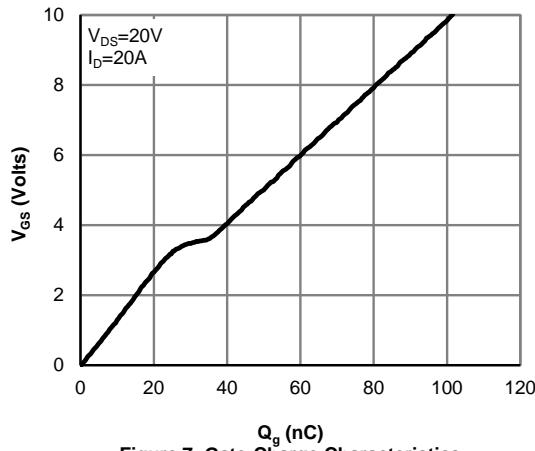
G. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{ C}$ .

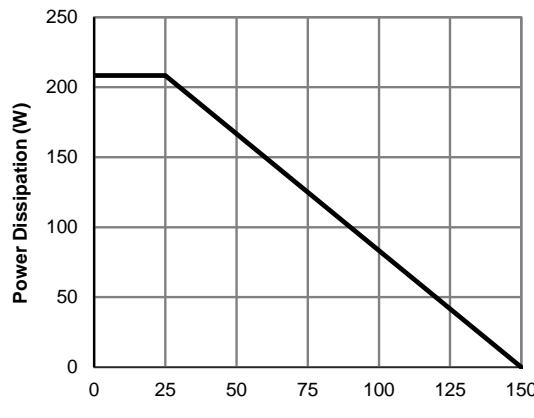
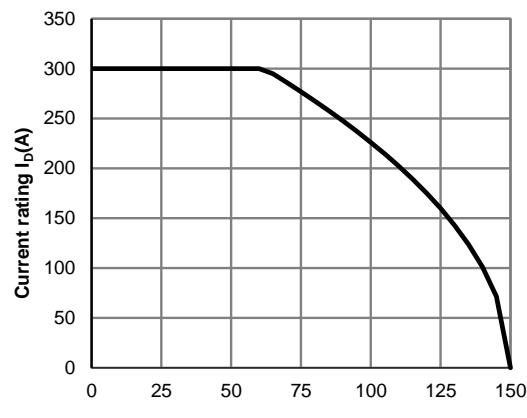
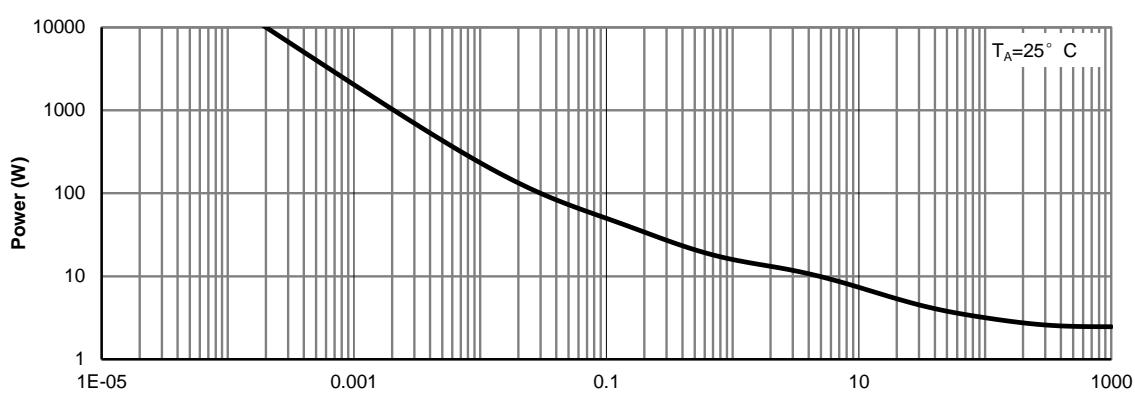
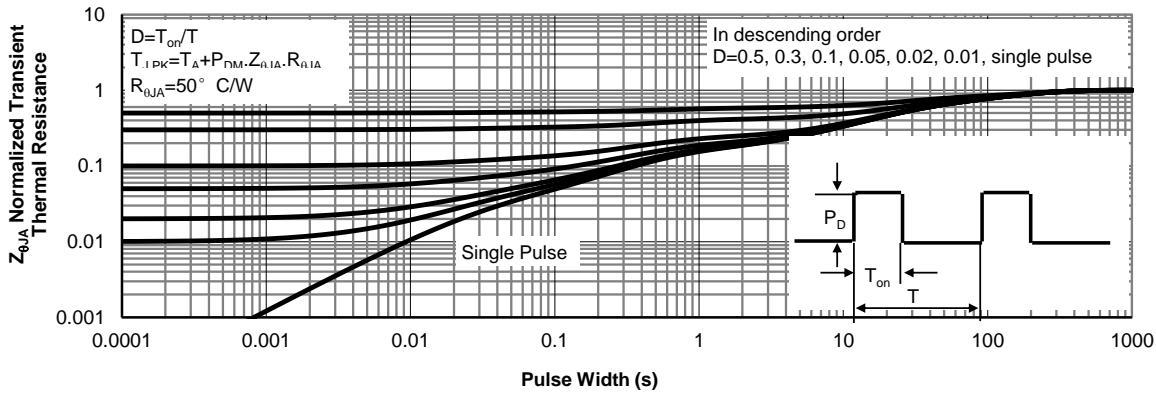
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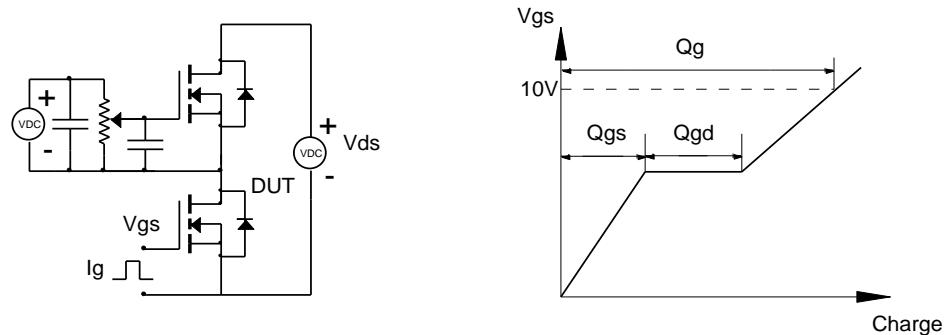
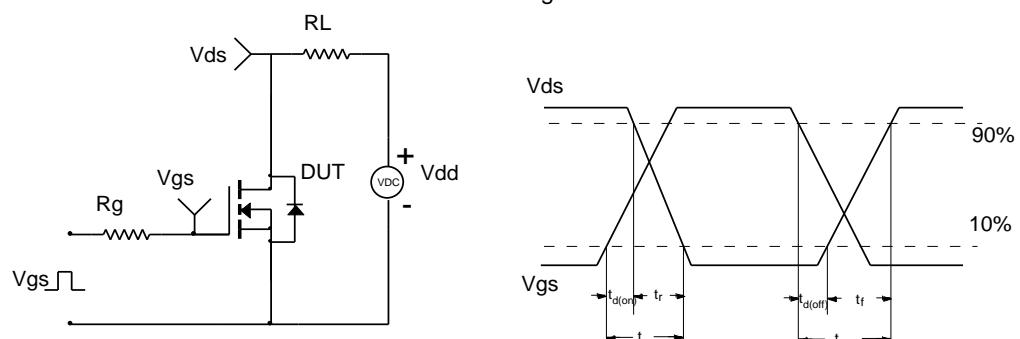
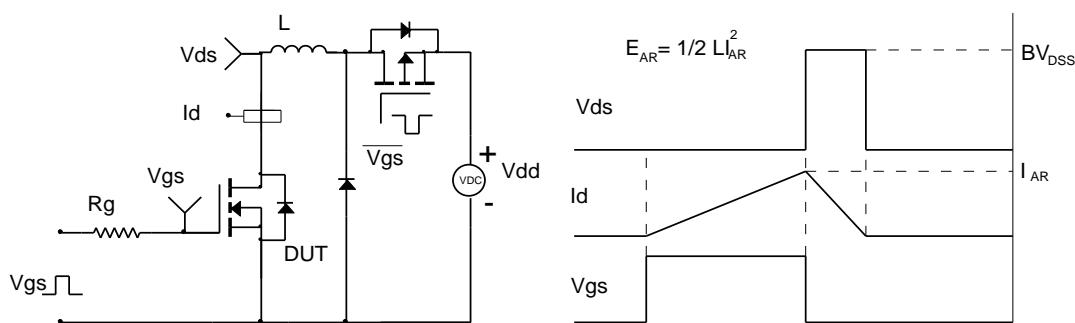
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**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**


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**Figure 12: Power De-rating (Note F)**

**Figure 13: Current De-rating (Note F)**

**Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note G)**

**Figure 15: Normalized Maximum Transient Thermal Impedance (Note G)**

**Gate Charge Test Circuit & Waveform**

**Resistive Switching Test Circuit & Waveforms**

**Unclamped Inductive Switching (UIS) Test Circuit & Waveforms**

**Diode Recovery Test Circuit & Waveforms**
